Notice of References Cited

Application/Control No.

10/765,100

Examiner

Mai-Huong Tran

Applicant(s)/Patent Under
Reexamination
SHIN, JOHNGEON

Art Unit
Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K,	US-			
	L	US-			
, , ,	М	US-			

FOREIGN PATENT DOCUMENTS

*	_	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Ćountry	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т				,	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ	Shibata et al., Semiconductor Element, US 2002/0125491 A1, Pub. Date 09/12/02.					
	٧	Sone et al., Method for Growing High Quality Group-III Nitride Thin Film by Metal Organic Chemical Vapor Deposition, US 2002/0192373 A1, Pub. Date 12/19/02.					
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.